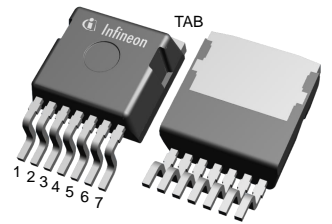


## CoolSiC™ 1200 V SiC Trench MOSFET : Silicon Carbide MOSFET

### Features

- $V_{DS} = 1200\text{ V}$  at  $T_{vj} = -55...175\text{ °C}$
- $I_{DC} = 205\text{ A}$  at  $T_C = 25\text{ °C}$
- $R_{DS(on)} = 8.7\text{ m}\Omega$  at  $V_{GS} = 20\text{ V}$ ,  $T_{vj} = 25\text{ °C}$
- New performance-optimized chip technology (Gen1p) with improved  $R_{DS(on)}$  \* A FOM
- Best in class switching energy for lower switching losses and reduced cooling efforts
- Lowest device capacitances for higher switching speeds and higher power density
- A combination of low  $C_{rSS}/C_{iSS}$  ratio and high  $V_{GS(th)}$  to avoid parasitic turn-on and enable unipolar gate driving
- Reduced total gate charge  $Q_{Gtot}$  for lower driving power and losses
- Increased recommended turn-on voltage ( $V_{GS(on)} = 20\text{ V}$ ) for lower  $R_{DS(on)}$
- .XT die attach technology for best in class thermal performance
- Low package stray inductance for faster and cleaner switching
- Sense (Kelvin) source pin for better gate control and reduced switching losses
- Minimal creepage distance 5.85 mm (material group II) to fit 800 V applications without coating
- SMT package for automated assembly and reduced system costs



Halogen-free



Green



Lead-free



RoHS

### Potential applications

- On-board charger
- DC/DC converter
- Auxiliary drives

### Product validation

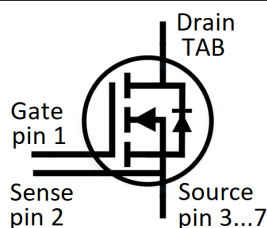
- Qualified for Automotive Applications. Product Validation according to AEC-Q100/101

### Description

Pin definition:

- Pin 1 - Gate
- Pin 2 - Kelvin sense contact
- Pin 3...7 - Source
- Tab - Drain

Note: The source and sense pins are not exchangeable, their exchange might lead to malfunction



Type	Package	Marking
AIMBG120R010M1	PG-TO263-7-HV-ND5.8	AS10MM1

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## 1 Package

**Table 1** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Storage temperature	$T_{stg}$		-55		150	°C
Soldering temperature	$T_{sold}$				260	°C
MOSFET/body diode thermal resistance, junction-case	$R_{th(j-c)}$			0.13	0.17	K/W

Note: Not subject to production test. Parameter verified by design/characterization.

## 2 MOSFET

**Table 2** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Drain-source voltage	$V_{DSS}$	$T_{vj} = -55...175\text{ °C}$	1200	V	
Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$	$I_{DCC}$	$V_{GS} = 20\text{ V}$	$T_c = 25\text{ °C}$	205	A
			$T_c = 100\text{ °C}$	150	
Peak drain current, $t_p$ limited by $T_{vj(max)}$	$I_{DM}$	$V_{GS} = 20\text{ V}$	540	A	
Gate-source voltage, max. transient voltage <sup>1)</sup>	$V_{GS}$	$t_p \leq 0.5\ \mu\text{s}, D < 0.01$	-10...25	V	
Gate-source voltage, max. static voltage	$V_{GS}$		-5...23	V	
Avalanche energy, single pulse	$E_{AS}$	$I_D = 70\text{ A}, V_{DD} = 50\text{ V}, L = 0.26\text{ mH}$	625	mJ	
Power dissipation, limited by $T_{vj(max)}$	$P_{tot}$		$T_c = 25\text{ °C}$	882	W
			$T_c = 100\text{ °C}$	441	

1) **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

**Table 3** Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
Recommended turn-on gate voltage	$V_{GS(on)}$		20	V
Recommended turn-off gate voltage	$V_{GS(off)}$		0	V

**Table 4** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-state resistance <sup>1)</sup>	$R_{DS(on)}$	$I_D = 93 \text{ A}$	$T_{vj} = 25 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		8.7	11.3	mΩ
			$T_{vj} = 100 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		12.2		
			$T_{vj} = 175 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		17.3		
			$T_{vj} = 25 \text{ °C}$ , $V_{GS(on)} = 18 \text{ V}$		9.1		
Gate-source threshold voltage <sup>1)</sup>	$V_{GS(th)}$	$I_D = 30.4 \text{ mA}$ , $V_{DS} = V_{GS}$ (tested after 1 ms pulse at $V_{GS} = 20 \text{ V}$ )	$T_{vj} = 25 \text{ °C}$	3.5	4.3	5.1	V
			$T_{vj} = 175 \text{ °C}$		3.8		
Zero gate-voltage drain current	$I_{DSS}$	$V_{DS} = 1200 \text{ V}$ , $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ °C}$		0.6	90	μA
			$T_{vj} = 175 \text{ °C}$		1.8		
Gate leakage current	$I_{GSS}$	$V_{DS} = 0 \text{ V}$	$V_{GS} = 25 \text{ V}$			100	nA
			$V_{GS} = -10 \text{ V}$			-100	
Forward transconductance	$g_{fs}$	$I_D = 93 \text{ A}$ , $V_{DS} = 20 \text{ V}$		78		S	
Short-circuit withstand time <sup>2)</sup>	$t_{SC}$	$V_{DD} \leq 800 \text{ V}$ , $V_{DS,peak} < 1200 \text{ V}$ , $T_{vj(start)} = 25 \text{ °C}$ , $R_{G,ext} = 2 \text{ } \Omega$	$V_{GS(on)} = 20 \text{ V}$		1.5		μs
			$V_{GS(on)} = 18 \text{ V}$		2		
			$V_{GS(on)} = 15 \text{ V}$		2.5		
Internal gate resistance	$R_{G,int}$	$f = 1 \text{ MHz}$ , $V_{AC} = 25 \text{ mV}$		2.4		Ω	
Input capacitance	$C_{iss}$	$V_{DD} = 800 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$		5703		pF	
Output capacitance	$C_{oss}$	$V_{DD} = 800 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$		268		pF	
Reverse transfer capacitance	$C_{riss}$	$V_{DD} = 800 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$		16		pF	
$C_{oss}$ stored energy	$E_{oss}$	$V_{DD} = 800 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$		107		μJ	
Total gate charge	$Q_G$	$V_{DD} = 800 \text{ V}$ , $I_D = 93 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse		178		nC	
Plateau gate charge	$Q_{GS(pl)}$	$V_{DD} = 800 \text{ V}$ , $I_D = 93 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse		48		nC	
Gate-to-drain charge	$Q_{GD}$	$V_{DD} = 800 \text{ V}$ , $I_D = 93 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse		30		nC	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 800 \text{ V}$ , $I_D = 93 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{GS(on)} = 2 \text{ } \Omega$ , $R_{GS(off)} = 2 \text{ } \Omega$ , $L_\sigma = 15 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ °C}$		14		ns
			$T_{vj} = 175 \text{ °C}$		13		

(table continues...)

**Table 4 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rise time	$t_r$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		23	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		27	
Turn-off delay time	$t_{d(off)}$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		52	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		55	
Fall time	$t_f$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		15	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		16	
Turn-on energy	$E_{on}$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		757	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		1156	
Turn-off energy	$E_{off}$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		805	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		932	
Total switching energy	$E_{tot}$	$V_{DD} = 800 \text{ V}, I_D = 93 \text{ A},$ $V_{GS} = 0/20 \text{ V},$ $R_{GS(on)} = 2 \Omega,$ $R_{GS(off)} = 2 \Omega, L_\sigma = 15 \text{ nH},$ diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		1561	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		2088	
Virtual junction temperature	$T_{vj}$			-55	175	$^\circ\text{C}$

- 1) **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.
- 2) verified by the design/characterization.

*Note: Characteristics at  $T_{vj} = 25^\circ\text{C}$ , unless otherwise specified.*

### 3 Body diode (MOSFET)

**Table 5** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Drain-source voltage	$V_{DSS}$	$T_{vj} = -55...175\text{ °C}$	1200	V	
Continuous reverse drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$	$I_{SDC}$	$V_{GS} = 0\text{ V}$	$T_c = 25\text{ °C}$	176	A
			$T_c = 100\text{ °C}$	103	
Peak reverse drain current, $t_p$ limited by $T_{vj(max)}$	$I_{SM}$	$V_{GS} = 0\text{ V}$	208	A	

**Table 6** Characteristic values

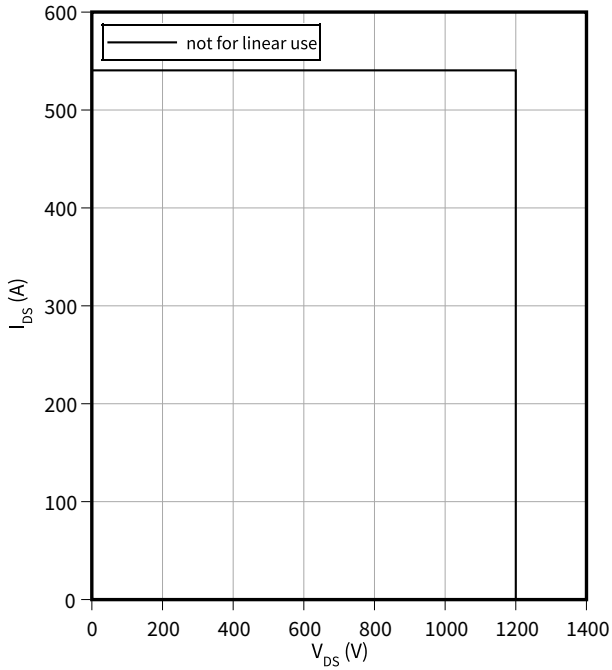
Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source reverse voltage	$V_{SD}$	$I_{SD} = 93\text{ A}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	3.9	5	V
			$T_{vj} = 100\text{ °C}$	3.8		
			$T_{vj} = 175\text{ °C}$	3.7		
MOSFET forward recovery charge	$Q_{fr}$	$V_{DD} = 800\text{ V}, I_{SD} = 93\text{ A}, V_{GS} = 0\text{ V}, di_{SD}/dt = 3000\text{ A}/\mu\text{s}, Q_{fr}$ includes also $Q_C$	$T_{vj} = 25\text{ °C}$	350		nC
			$T_{vj} = 175\text{ °C}$	970		
MOSFET peak forward recovery current	$I_{frm}$	$V_{DD} = 800\text{ V}, I_{SD} = 93\text{ A}, V_{GS} = 0\text{ V}, di_{SD}/dt = 3000\text{ A}/\mu\text{s}, Q_{fr}$ includes also $Q_C$	$T_{vj} = 25\text{ °C}$	23		A
			$T_{vj} = 175\text{ °C}$	33		
Virtual junction temperature	$T_{vj}$		-55		175	°C

## 4 Characteristics diagrams

### Reverse bias safe operating area (RBSOA)

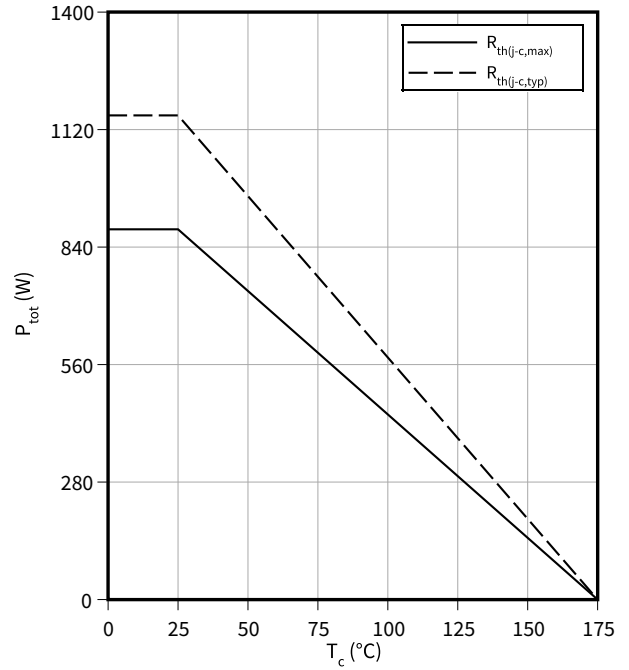
$$I_{DS} = f(V_{DS})$$

$$T_{vj} \leq 175\text{ °C}, V_{GS} = 0/20\text{ V}, T_c = 25\text{ °C}$$



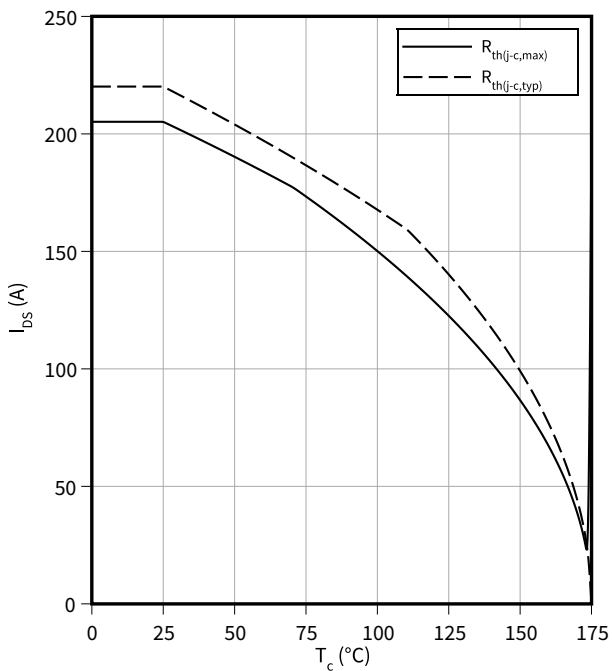
### Power dissipation as a function of case temperature

$$P_{tot} = f(T_c)$$



### Maximum DC drain to source current as a function of case temperature

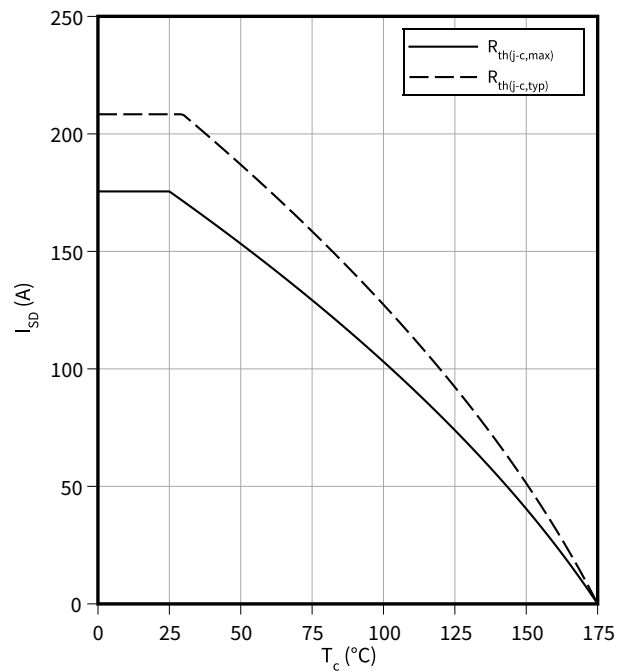
$$I_{DS} = f(T_c)$$



### Maximum source to drain current as a function of case temperature

$$I_{SD} = f(T_c)$$

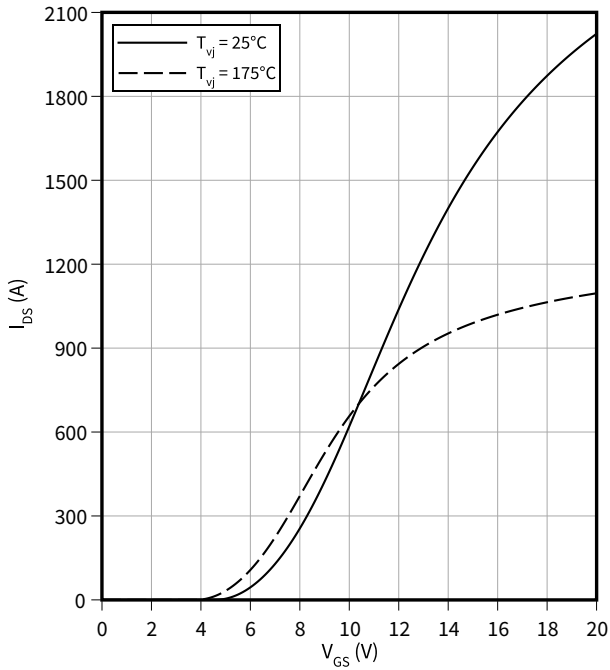
$$V_{GS} = 0\text{ V}$$



4 Characteristics diagrams

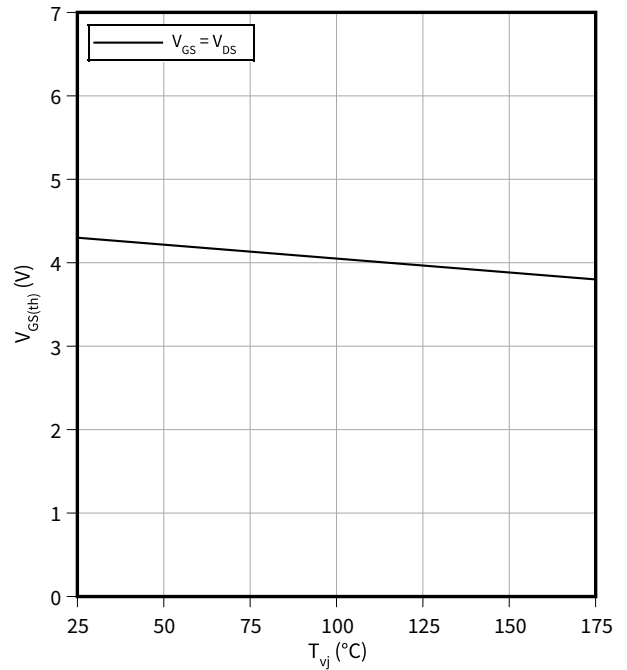
**Typical transfer characteristic**

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20 \text{ V}$



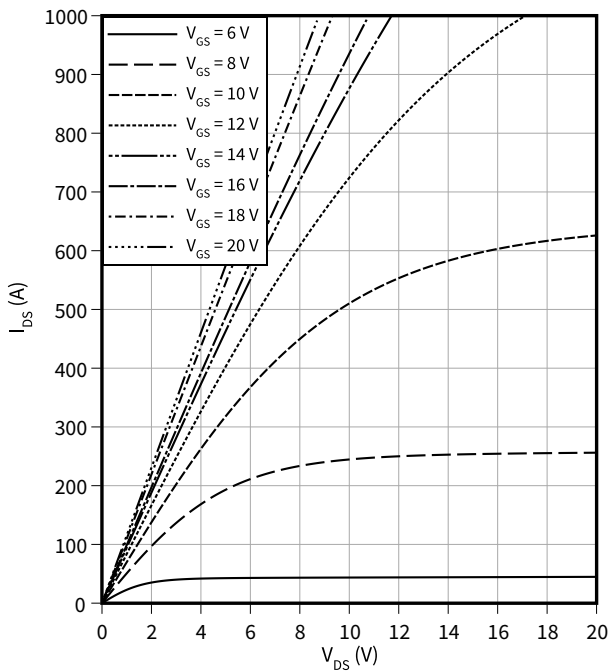
**Typical gate-source threshold voltage as a function of junction temperature**

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 30.4 \text{ mA}$



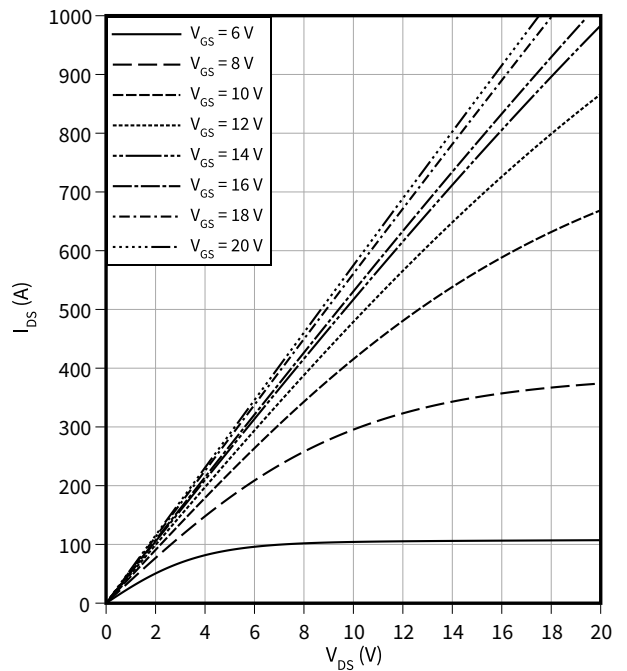
**Typical output characteristic,  $V_{GS}$  as parameter**

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25^\circ\text{C}$



**Typical output characteristic,  $V_{GS}$  as parameter**

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175^\circ\text{C}$

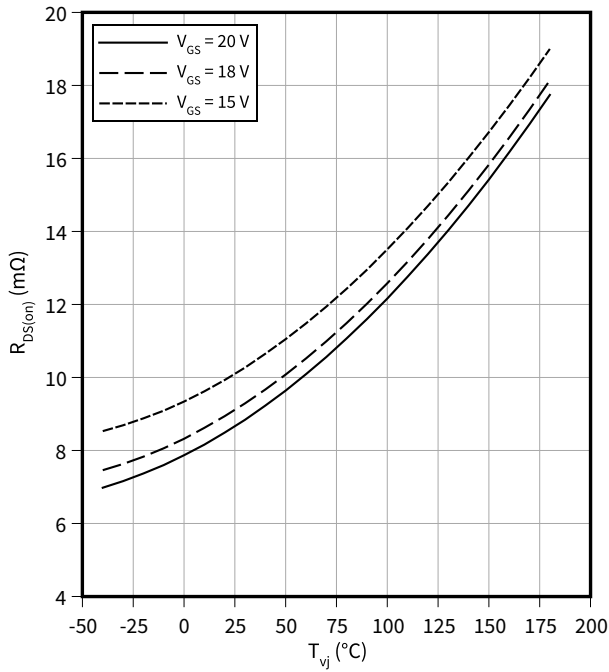




4 Characteristics diagrams

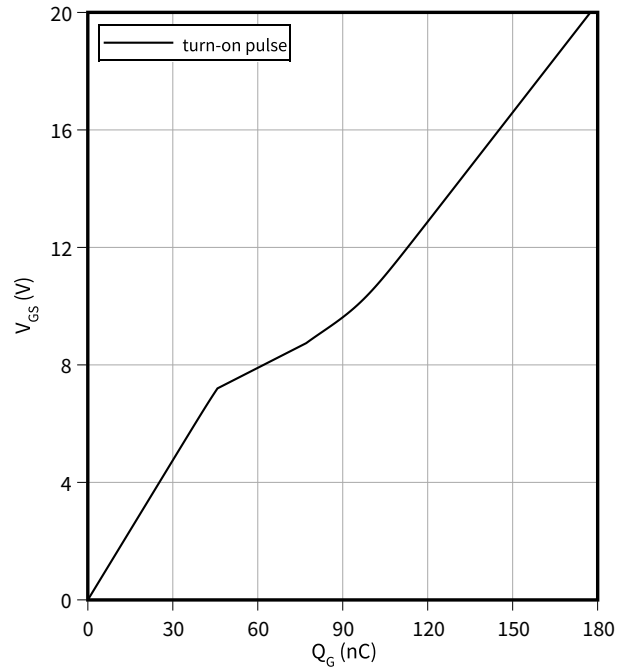
**Typical on-state resistance as a function of junction temperature**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 93 \text{ A}$



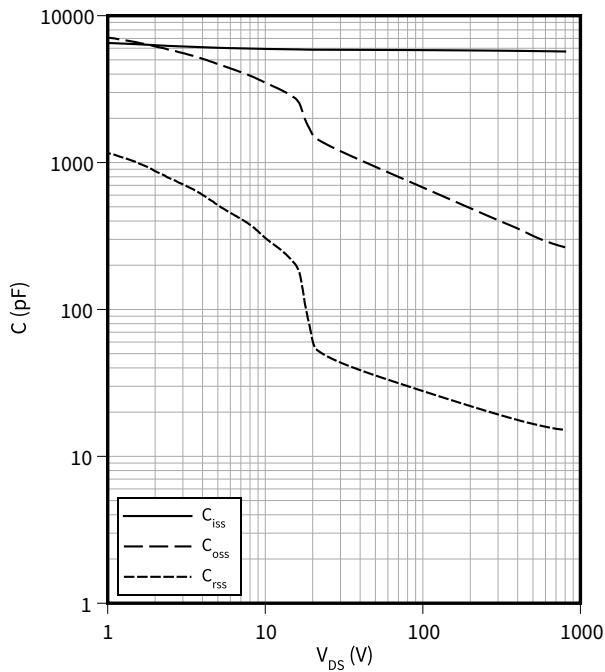
**Typical gate charge**

$V_{GS} = f(Q_G)$   
 $I_D = 93 \text{ A}, V_{DS} = 800 \text{ V}$



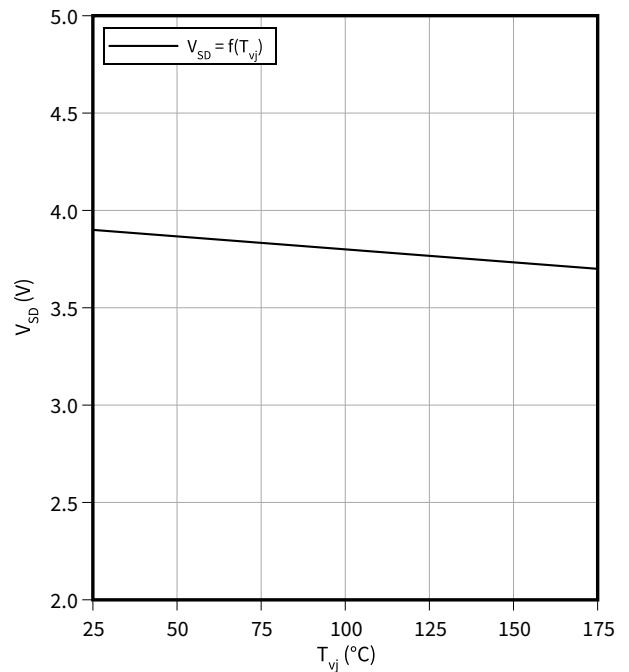
**Typical capacitance as a function of drain-source voltage**

$C = f(V_{DS})$   
 $f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$



**Typical reverse drain voltage as function of junction temperature**

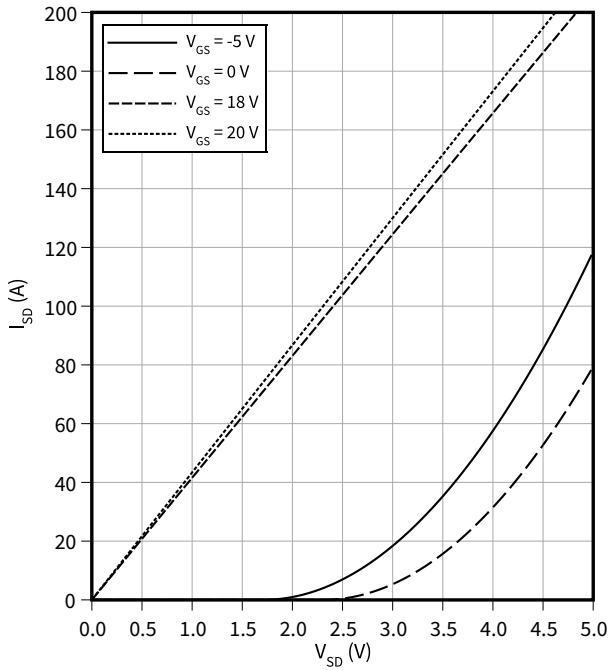
$V_{SD} = f(T_{vj})$   
 $I_{SD} = 93 \text{ A}, V_{GS} = 0 \text{ V}$



4 Characteristics diagrams

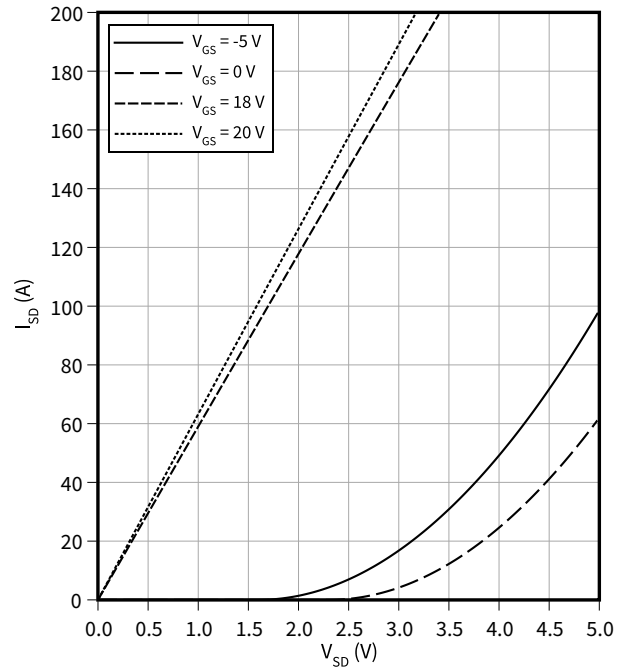
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 175\text{ °C}$



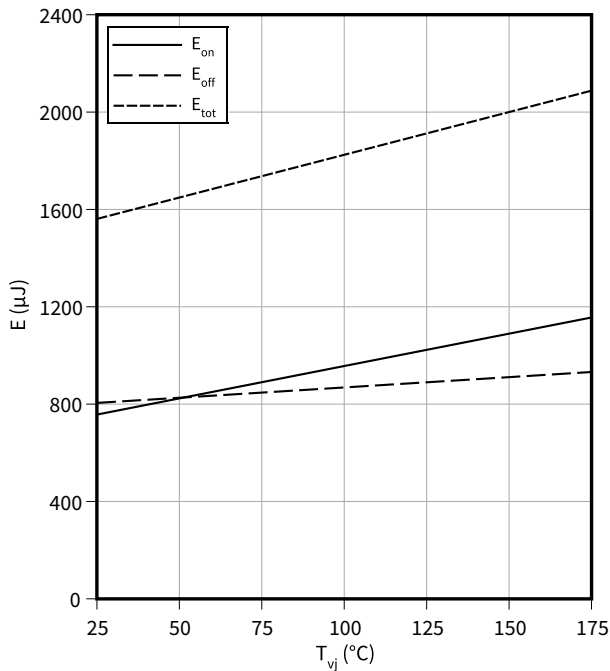
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25\text{ °C}$



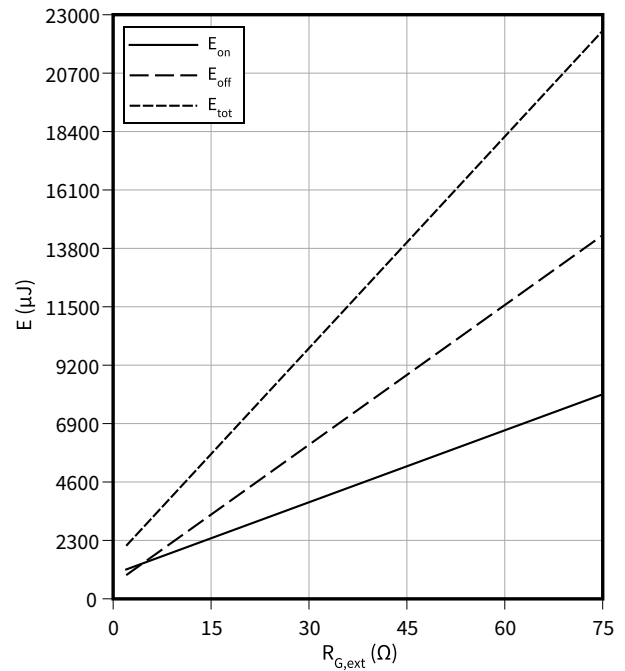
**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(T_{vj})$   
 $V_{GS} = 0/20\text{ V}$ ,  $I_D = 93\text{ A}$ ,  $R_{G,ext} = 2\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



**Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(R_{G,ext})$   
 $V_{GS} = 0/20\text{ V}$ ,  $I_D = 93\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$

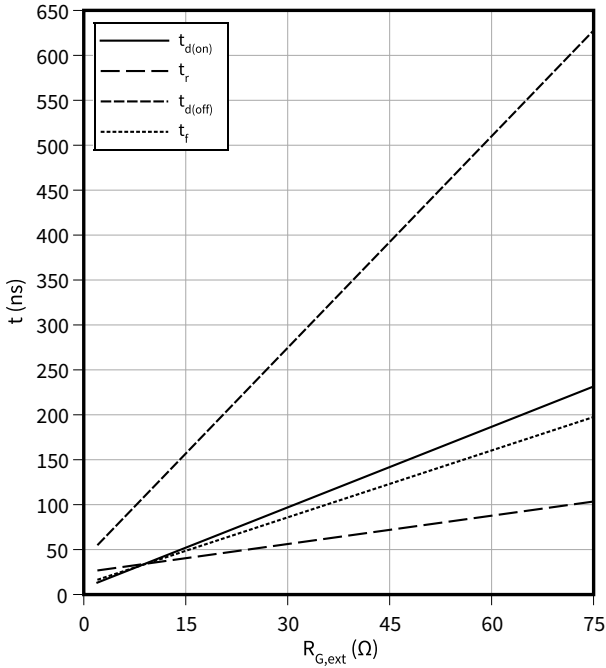


4 Characteristics diagrams

**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$t = f(R_{G,ext})$

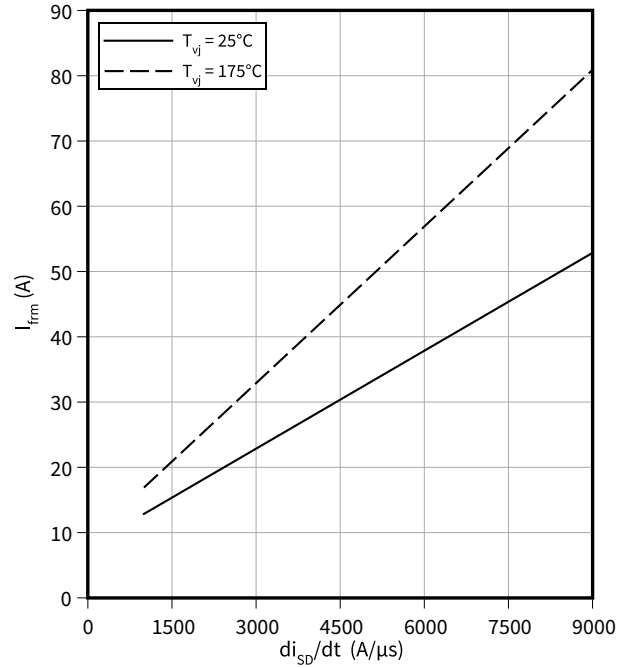
$V_{GS} = 0/20\text{ V}$ ,  $I_D = 93\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$



**Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$I_{frm} = f(di_{SD}/dt)$

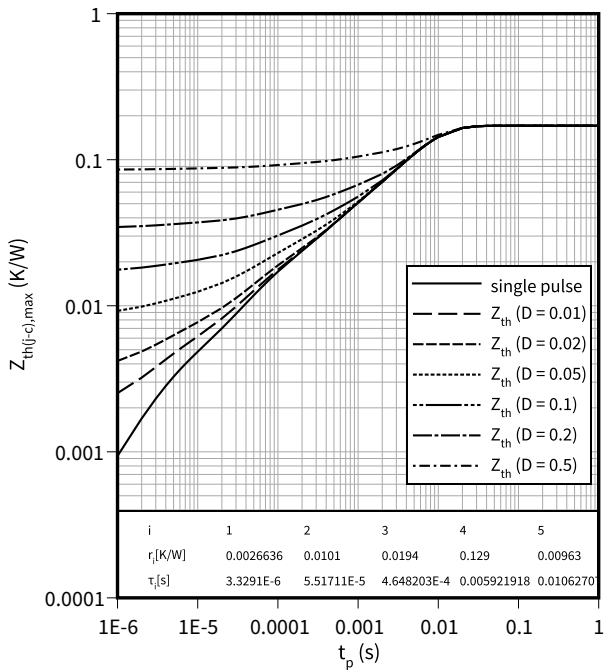
$V_{GS} = 0/20\text{ V}$ ,  $I_{SD} = 93\text{ A}$ ,  $V_{DD} = 800\text{ V}$



**Max. transient thermal impedance (MOSFET/diode)**

$Z_{th(j-c),max} = f(t_p)$

$D = t_p/T$



5 Package outlines

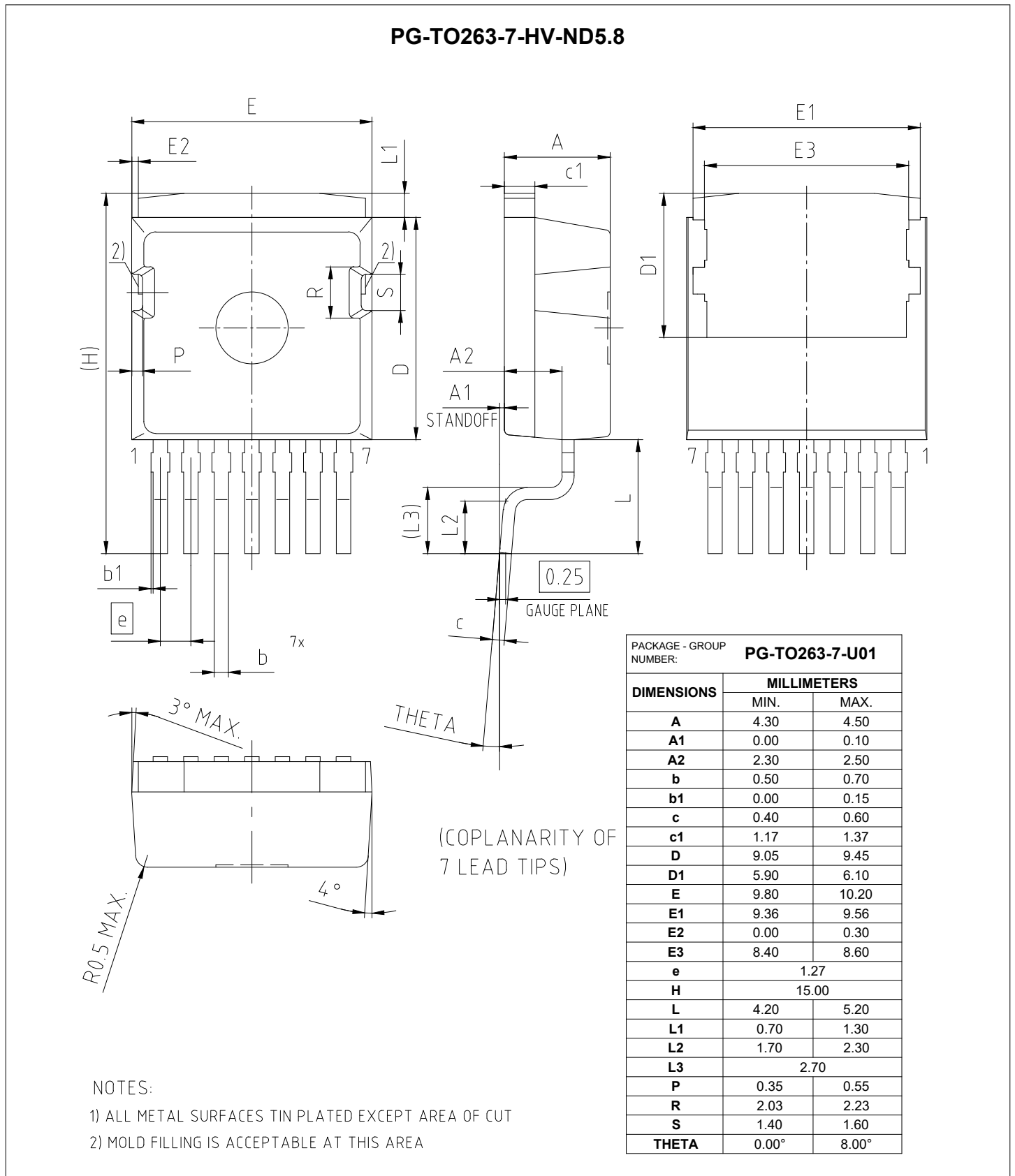
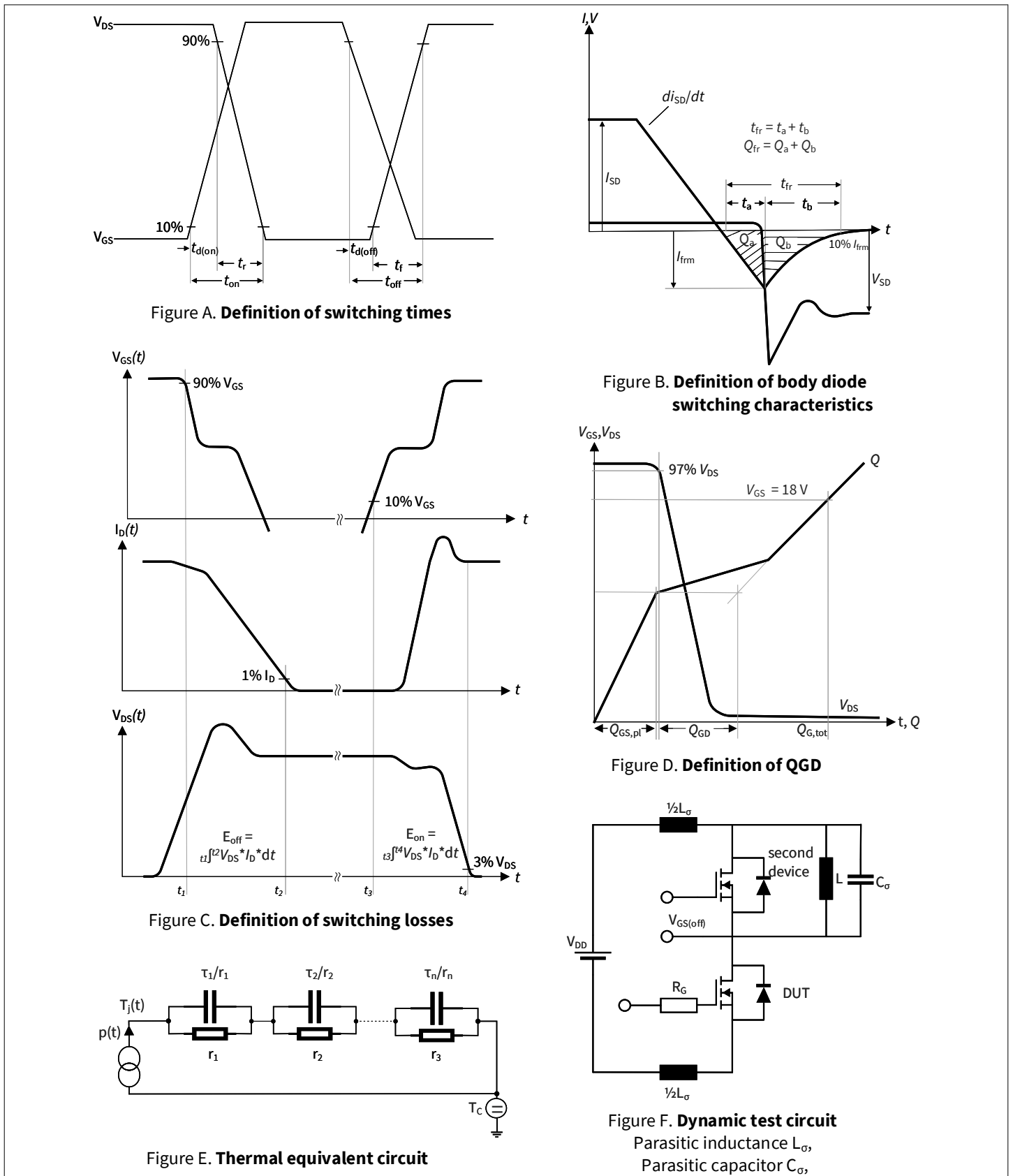


Figure 1

## 6 Testing conditions



**Figure 2**

## Revision history

Document revision	Date of release	Description of changes
0.10	2022-11-15	Preliminary datasheet
1.00	2023-04-25	Final datasheet

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**IFX-ABG000-002**

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Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.